



TEST DATA SHEET

Customer: _____

Note: _____

Model No: 955A-27/34/40/40/599/HAC

Serial No: _____

Item No:	Specification		Test Data		
			Low	Center	High
1.	Frequency	27-34GHz	27	30	33
2.	Small Signal Gain	40dB typ	49	45	40
3.	Output Power (Psat)	+36dBm typ	41.5	41.1	40.4
4.	Input Drive Level	+5dBm typ	+5dBm to +10dBm @ Psat		
5.	Input/Output Return Loss (dB)	2.0 :1 typ	1.92 :1		
6.	Bias Voltage	100V - 200V AC			
7.	Maximum RF Input Power	+15dBm max			
8.					
9.					
10.					

Notes:

Millimeter Wave Products Inc and the signee of this document certify that the below signee has tested the listed products above and have met quality test data standards. Mi-Wave test data sheets have been produced in our lab under typical operating conditions. Source inspection of material or components by the Buyer or any designate of his will be quoted as a separate line item. Failure to include this line item will not relieve the Buyer from the obligation of payment for said service. Source inspection that requires witnessing of electrical tests must be preceded by mutual acceptance of a test procedure. Such test procedure, if generated by Mi-Wave, will be at the expense of the Buyer.

Tested by: _____

Date: _____